PRODUCT AND PROCESS CHANGE NOTIFICATION

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ISSUE DATE:	07-Jun-2012
NOTIFICATION:	15207
TITLE:	9S08QD4/2 NEW MASKSET 2M15D DESIGN FIX
EFFECTIVE DATE:	05-Sep-2012

DEVICE(S)

MPN
MC9S08QD2CPC
MC9S08QD2CSC
MC9S08QD2CSCR
MC9S08QD2MPC
MC9S08QD2MSC
MC9S08QD2MSCR
MC9S08QD2VPC
MC9S08QD2VSC
MC9S08QD2VSCR
MC9S08QD4CPC
MC9S08QD4CSC
MC9S08QD4CSCR
MC9S08QD4MPC
MC9S08QD4MSC
MC9S08QD4MSCR
MC9S08QD4VPC
MC9S08QD4VSC
PC9S08QD4W0MSC

AFFECTED CHANGE CATEGORIES

- DESIGN CHANGE
- MASK SET REV (SAME FAB SITE)

DESCRIPTION OF CHANGE

Freescale Semiconductor is pleased to announce the qualification of new maskset 2M15D for MC9S08QD4/2. With the enhancement made on this new maskset , maskset 1M15D errata "SE195-HIGHIDD: High IDD issue with high temperature power-up" has been fixed.

REASON FOR CHANGE

The release and implementation of the new maskset 2M15D is to fix the known maskset 1M15D errata (SE195-HIGHIDD: High IDD issue with high temperature power-up).

ANTICIPATED IMPACT OF PRODUCT CHANGE(FORM, FIT, FUNCTION, OR RELIABILITY)

With the release of this new maskset 2M15D into production, the known errata (SE195-HIGHIDD: High IDD issue with high temperature power-up) which was seen on maskset 1M15D will be fixed.

Freescale will consider specific conditions of acceptance of this change submitted within 30 days of receipt of this notice on a case by case basis. To request further data or inquire about the notification, please enter a <u>Service Request.</u>

For sample inquiries - please go to www.freescale.com

QUAL DATA AVAILABILITY DATE: 01-Jun-2012

QUALIFICATION STATUS: COMPLETED

QUALIFICATION PLAN:

Refer to attached qualification report.

RELIABILITY DATA SUMMARY:

Refer to attached qualification report.

ELECTRICAL CHARACTERISTIC SUMMARY:

Electrical characterization was done and meets electrical specifications.

CHANGED PART IDENTIFICATION:

There is no change to the orderable part number or marking.

SAMPLE AVAILABILITY DATE: 01-Jun-2012

ATTACHMENT(S):

External attachment(s) FOR this notification can be viewed AT: <u>15207 QD4-2M15D revision-IMM.pdf</u>